

#### 1. General description

Planar passivated Silicon Controlled Rectifier (SCR) in a SOT186A (TO-220F) "full pack" plastic package intended for use in applications requiring good bidirectional blocking voltage and high current surge capability with high thermal cycling performance and high junction temperature capability ( $T_{i(max)} = 150$  °C).

#### 2. Features and benefits

- High junction operating temperature capability (T<sub>j(max)</sub> = 150 °C)
- · Good bidirectional blocking voltage capability
- High current surge capability
- High thermal cycling performance
- Isolated mounting base package
- Planar passivated for voltage ruggedness and reliability

#### 3. Applications

- Capacitive Discharge Ignition (CDI)
- Crowbar protection
- Inrush protection
- Motor control
- Voltage regulation
- High junction operating temperature capability (T<sub>j(max)</sub> = 150 °C)

#### 4. Quick reference data

Symbol	Parameter	Conditions	Values	Unit
Absolute m	aximum rating			,
V <sub>RRM</sub>	repetitive peak reverse voltage		650	V
I <sub>T(RMS)</sub>	RMS on-state current	half sine wave; $T_h \le 94 \degree C$ ; Fig. 1; Fig. 2; Fig. 3	12	A
I <sub>TSM</sub>	non-repetitive peak on- state current	half sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 10 ms; Fig. 4; Fig. 5	120	A
		half sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 8.3 ms	132	А
T <sub>j</sub>	junction temperature		150	°C

# BT151X-650LT

SCR

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static characteristics						
I <sub>GT</sub>	gate trigger current	$V_{D}$ = 12 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 25 °C; <u>Fig. 7</u>	-	-	5	mA
I <sub>H</sub>	holding current	V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; <u>Fig. 9</u>	-	7	20	mA
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 12 A; T <sub>j</sub> = 25 °C; <u>Fig. 10</u>	-	1.18	1.54	V
Dynamic	characteristics					
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 436 V; T <sub>j</sub> = 150 °C; R <sub>GK</sub> = 100 $\Omega$ ; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform;	200	1000	-	V/µs

# **5. Pinning information**

Table 2. Pinning information							
Pin	Symbol	Description	Simplified outline	Graphic symbol			
1	К	cathode	mb	А Ӈ К			
2	А	anode		G sym037			
3	G	gate		Symoor			
mb	n.c.	mounting base; isolated					

## 6. Ordering information

Table 3. Ordering information							
Type number	Package	Package					
	Name	Description	Version				
BT151X-650LT	TO-220F	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 "full pack"	SOT186A				

# 7. Marking

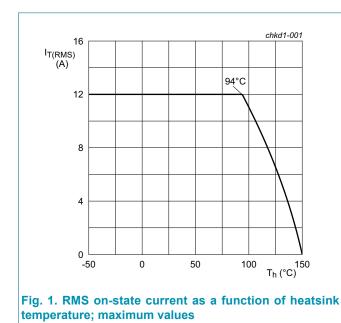
Table 4. Marking codes					
	Type number	Marking codes			
	BT151X-650LT	BT151X-650LT			

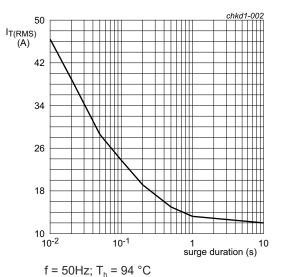
## 8. Limiting values

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
$V_{\text{DRM}}$	repetitive peak off-state voltage		650	V
$V_{\text{RRM}}$	repetitive peak reverse voltage		650	V
I <sub>T(AV)</sub>	average on-state current	half sine wave; $T_h \le 94 \degree C$ ;	7.5	А
I <sub>T(RMS)</sub>	RMS on-state current	half sine wave; $T_h \le 94$ °C; Fig. 1; Fig. 2; Fig. 3	12	A
I <sub>TSM</sub>	non-repetitive peak on- state current	half sine wave; T <sub>j(init)</sub> = 25 °C; t <sub>p</sub> = 10 ms; Fig. 4; Fig. 5	120	A
		half sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 8.3 ms	132	А
l <sup>2</sup> t	l <sup>2</sup> t for fusing	t <sub>p</sub> = 10 ms; sine wave	72	A <sup>2</sup> s
dI <sub>⊤</sub> /dt	rate of rise of on-state current	I <sub>G</sub> = 10 mA	50	A/µs
I <sub>GM</sub>	peak gate current		2	А
$V_{\text{GM}}$	peak gate voltage		5	V
P <sub>GM</sub>	peak gate power		5	W
P <sub>G(AV)</sub>	average gate power	over any 20 ms period	0.5	W
T <sub>stg</sub>	storage temperature		-40 to 150	°C
Tj	junction temperature		150	°C

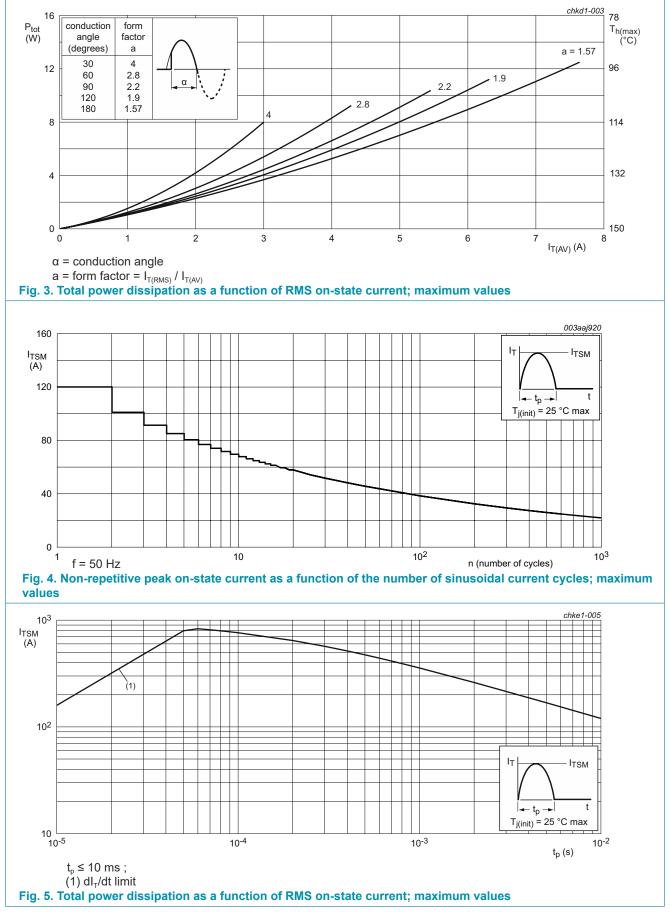






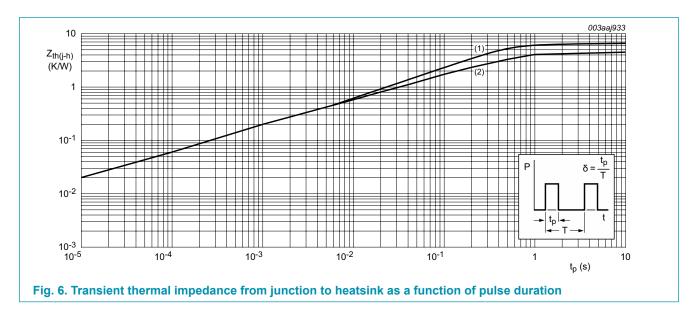
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## 9. Thermal characteristics

Table 6. Thermal characteristics							
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R <sub>th(j-h)</sub> thermal resistance from junction to heatsink	with heatsink compound; <u>Fig. 6</u>		-	-	4.5	K/W	
		without heatsink compound; Fig. 6		-	-	6.5	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient free air	in free air		-	55	-	K/W

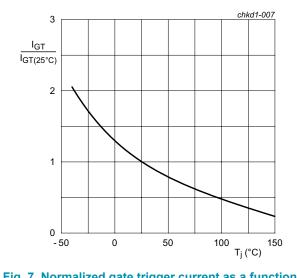


## **10. Isolation characteristics**

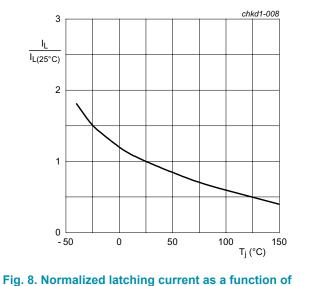
Table 7. Isolation characteristics							
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V <sub>isol(RMS)</sub>	RMS isolation voltage	50 Hz $\leq$ f $\leq$ 60 Hz; RH $\leq$ 65 %; from all pins to external heatsink; sinusoidal waveform; clean and dust free		-	-	2500	V
C <sub>isol</sub>	isolation capacitance	from cathode to external heatsink		-	10	-	PF

## **11. Characteristics**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics	I				_
I <sub>GT</sub>	gate trigger current	V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 25 °C; <u>Fig. 7</u>	-	-	5	mA
I <sub>L</sub>	latching current	V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 25 °C; <u>Fig. 8</u>	-	10	40	mA
I <sub>H</sub>	holding current	V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; <u>Fig. 9</u>	-	7	20	mA
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 12 A; T <sub>j</sub> = 25 °C; <u>Fig. 10</u>	-	1.18	1.54	V
V <sub>gt</sub>	gate trigger voltage	$V_{D} = 12 \text{ V}; I_{T} = 0.1 \text{ A}; T_{j} = 25 \text{ °C};$ Fig. 11	-	0.6	1	V
		$V_{\rm D}$ = 400 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 150 °C; Fig. 11	0.2	0.4	-	V
I <sub>D</sub>	off-state current	V <sub>D</sub> = 650 V; T <sub>j</sub> = 150 °C	-	-	1	mA
I <sub>R</sub>	reverse current	V <sub>D</sub> = 650 V; T <sub>j</sub> = 150 °C	-	-	1	mA
Dynamic o	haracteristics	· · · · · · · · · · · · · · · · · · ·				
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 436 V; T <sub>j</sub> = 150 °C; R <sub>GK</sub> = 100 $\Omega$ ; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform;	200	1000	-	V/µs
		$V_{DM}$ = 436 V; T <sub>j</sub> = 150 °C; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform; gate open circuit	50	-	-	V/µs
t <sub>gt</sub>	gate-controlled turn-on time	$I_{TM} = 12 \text{ A}; V_D = 650 \text{ V}; I_G = 10 \text{ mA};$ $(dI_G/dt)_M = 5 \text{ A}/\mu\text{s}; T_j = 25 \text{ °C}$		2	-	μs
t <sub>q</sub>	commutated turn-off time			70	-	μs



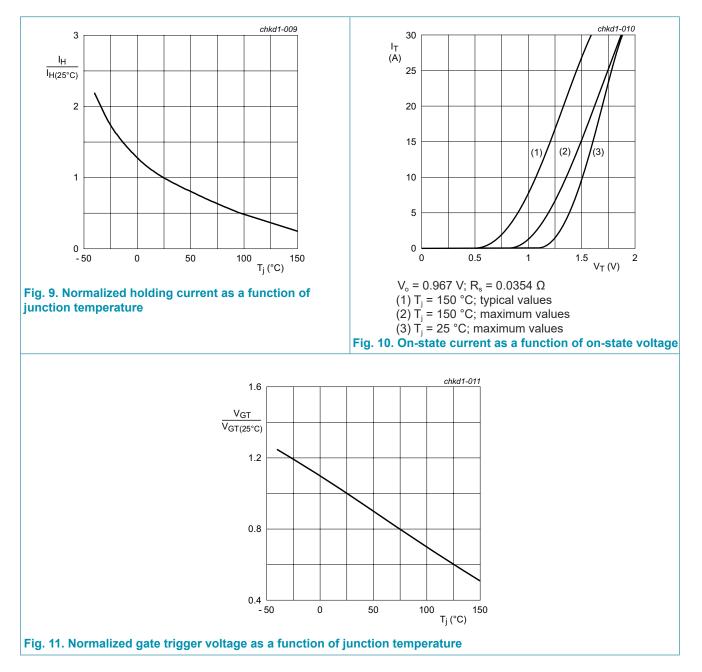




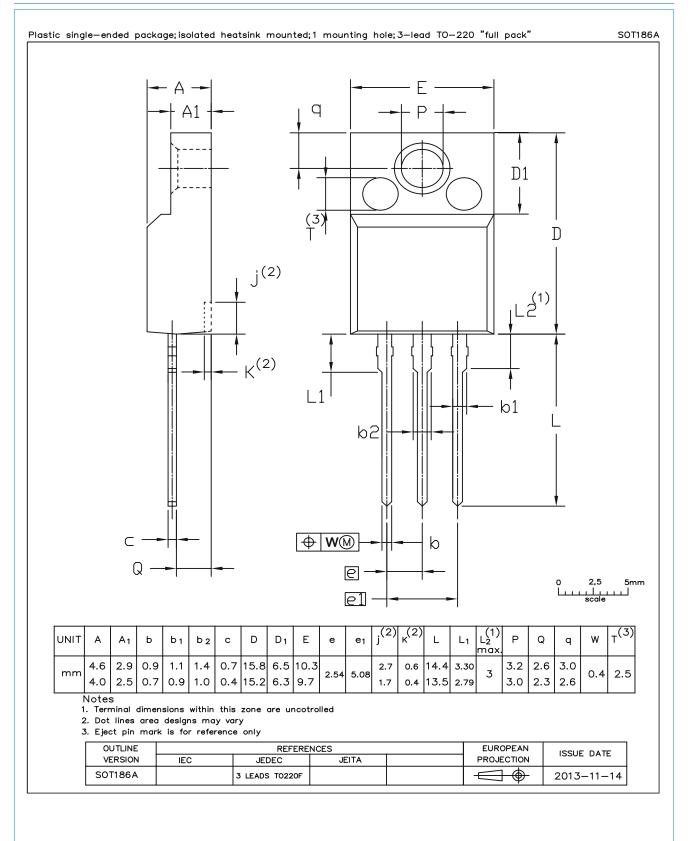


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## 12. Package outline



## 13. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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